

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/740,208	KERC, JANEZ	
Examiner	Art Unit	
Sharon E. Kennedy	1615	

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SEARCHED					
Class	Subclass	Date	Examiner		
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INI	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
East See attached.	8 5 07	\$K		
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